

Search Notes

Application/Control No.

10/676,659

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

CHAVEZ ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	352	3/19/2007	HN
	401		
	389		
	225		
	216		
	218		
	219		
	242		
	356		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	3/19/2007	HN